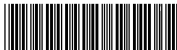


Search Notes**Application/Control No.**

10/553,043

Examiner

/Yonel Beaulieu/

**Applicant(s)/Patent under
Reexamination**

NIHEI ET AL.

Art Unit

3661

SEARCHED

Class	Subclass	Date	Examiner
701	1	9/15/2008	YB
	29		
	36		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST+Inv.'s Name Search	9/16/2008	YB